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PATENT NUMBER and
ISSUE DATE

U.S. UTILITY Patent Application

APPL NUM 10076508	FILING DATE 02/19/2002	CLASS 324	SUBCLASS 754	GAU 2829	EXAMINER TAN M. NII
<p>**APPLICANTS: Yoshida Hideaki; Ishii Toshinori; Matsuda Atushi; Ueki Mituyoshi; Tachikawa Noriyoshi; Nakamura Tadashi; Katou Naoki; Tai Shou; Sasaki Hayato; Iwamoto Naohumi; Mishima Akihumi; Hiji Toshiharu; Masuda Akihiro;</p>					
<p>**CONTINUING DATA VERIFIED: Yes MT THIS APPLICATION IS A DIV OF 08/862,414 05/23/1997 ABN</p>					
<p>** FOREIGN APPLICATIONS VERIFIED: Yes MT JAPAN 8-128570 05/23/1996 JAPAN 8-253829 09/30/1996 JAPAN 8-259831 09/30/1996</p>					
PG-PUB <input type="checkbox"/> DO NOT PUBLISH <input type="checkbox"/>		RESCIND <input type="checkbox"/>			
Foreign priority claimed <input checked="" type="checkbox"/> yes <input type="checkbox"/> no 35 USC 119 conditions met <input checked="" type="checkbox"/> yes <input type="checkbox"/> no Verified and Acknowledged Examiners's initials MT				ATTORNEY DOCKET NO 219891US2 DIV	
TITLE : Contact probe and probe device					

U.S. DEPT. OF COMM./PAT. & TM.-PTO-436L (Rev. 12-94)

NOTICE OF ALLOWANCE MAILED		CLAIMS ALLOWED	
		Total Claims	Print Claim for O.G.
ISSUE FEE		DRAWING	
Amount Due	Date Paid	Sheets Drwg.	Figs. Drwg. Print Fig.
<input type="checkbox"/> TERMINAL DISCLAIMER		Primary Examiner	
		PREPARED FOR ISSUE	
		Applicati n Examiner	
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